

<b>Notice of References Cited</b>	Application/Control No. 10/518,182	Applicant(s)/Patent Under Reexamination ROUTLEY ET AL.	
	Examiner Jason M. Mandeville	Art Unit 2609	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,414,661	07-2002	Shen et al.	345/82
*	C	US-6,738,031	05-2004	Young et al.	345/55
*	D	US-6,847,171	01-2005	Tam, Simon	315/169.3
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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